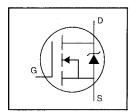
International Rectifier

HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DSS} = 60V$$

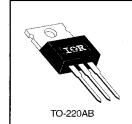
$$R_{DS(on)} = 0.028\Omega$$

$$I_{D} = 50*A$$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|-----------------------------------------|--------------------------------------------------|-----------------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10 V | 50* | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10 V | 36 | Α |
| I _{DM} | Pulsed Drain Current ① | 200 | |
| P _D @ T _C = 25°C | Power Dissipation | 150 | W |
| | Linear Derating Factor | 1.0 | W/°C |
| V _{GS} | Gate-to-Source Voltage | ±20 | V |
| Eas | Single Pulse Avalanche Energy ② | 100 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 4.5 | V/ns |
| TJ | Operating Junction and | -55 to +175 | |
| T _{STG} | Storage Temperature Range | | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |
| | Mounting Torque, 6-32 or M3 screw | 10 lbf•in (1.1 N•m) | |

Thermal Resistance

| | Parameter | Min. | Тур. | Max. | Units |
|------------------|-------------------------------------|------|------|------|-------|
| Reuc | Junction-to-Case | _ | _ | 1.0 | |
| Recs | Case-to-Sink, Flat, Greased Surface | | 0.50 | | °C/W |
| R _{0JA} | Junction-to-Ambient | _ | i | 62 | 1 |



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|---------------------------------|--------------------------------------|------|-------|-------|-------|------------------------------------------------------------------|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 60 | _ | _ | ٧ | V _{GS} =0V, I _D = 250μA |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | _ | 0.060 | _ | V/°C | Reference to 25°C, I _D = 1mA |
| RDS(on) | Static Drain-to-Source On-Resistance | _ | _ | 0.028 | Ω | V _{GS} =10V, I _D =31A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | _ | 4.0 | ٧ | V _{DS} =V _{GS} , I _D = 250μA |
| gfs | Forward Transconductance | 15 | _ | _ | S | V _{DS} =25V, I _D =31A ④ |
| | Busin to Course I calcana Course | _ | | 25 | μА | V _{DS} =60V, V _{GS} =0V |
| IDSS | Drain-to-Source Leakage Current | | _ | 250 | μΑ | V _{DS} =48V, V _{GS} =0V, T _J =150°C |
| 1 | Gate-to-Source Forward Leakage | | _ | 100 | nA | V _{GS} =20V |
| lgss | Gate-to-Source Reverse Leakage | | | -100 | IIA | V _{GS} =-20V |
| Qg | Total Gate Charge | | | 67 | | I _D =51A |
| Qgs | Gate-to-Source Charge | _ | _ | 18 | пC | V _{DS} =48V |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | _ | | 25 | | V _{GS} =10V See Fig. 6 and 13 ® |
| t _{d(on)} | Turn-On Delay Time | _ | 14 | _ | | V _{DD} =30V |
| t _r | Rise Time | _ | 110 | | ns | I _D =51A |
| t _{d(off)} | Turn-Off Delay Time | _ | 45 | _ | 110 | R _G =9.1Ω |
| t _f | Fall Time | | 92 | _ | | R _D =0.55Ω See Figure 10 @ |
| L _D | Internal Drain Inductance | _ | 4.5 | _ | пН | Between lead, 6 mm (0.25in.) |
| Ls | Internal Source Inductance | _ | 7.5 | | | from package and center of die contact |
| Ciss | Input Capacitance | _ | 1900 | | | V _{GS} =0V |
| Coss | Output Capacitance | _ | 920 | _ | pF | V _{DS} =25V |
| Crss | Reverse Transfer Capacitance | | 170 | | | f=1.0MHz See Figure 5 |

Source-Drain Ratings and Characteristics

| • | | | | | | |
|-----------------|----------------------------------------|----------|----------------------------------------------------------------------|------|-------|------------------------------------------------------------------|
| | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
| Is | Continuous Source Current (Body Diode) | _ | _ | 50* | А | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ① | - | _ | 200 | | integral reverse p-n junction diode. |
| V _{SD} | Diode Forward Voltage | | _ | 2.5 | ٧ | T _J =25°C, I _S =51A, V _{GS} =0V @ |
| t _{rr} | Reverse Recovery Time | | 120 | 180 | ns | T _J =25°C, I _F =51A |
| Qrr | Reverse Recovery Charge | - | 0.53 | 0.80 | μС | di/dt=100A/μs ④ |
| ton | Forward Turn-On Time | Intrinsi | Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+LD) | | | |

Notes:

- Repetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ I_{SD}≤51A, di/dt≤250A/μs, V_{DD}≤V(BR)DSS, T_J≤175°C
- ② V_{DD}=25V, starting T_J=25°C, L=44 μ H R_G=25Ω, I_{AS}=51A (See Figure 12)
- ④ Pulse width ≤ 300 μ s; duty cycle ≤2%.

^{*} Current limited by the package, (Die Current =51A)

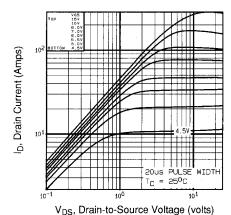


Fig 1. Typical Output Characteristics, Tc=25°C

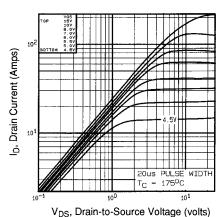


Fig 2. Typical Output Characteristics,

Tc=175°C

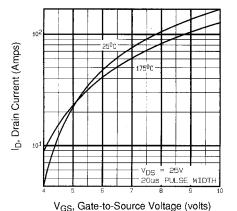


Fig 3. Typical Transfer Characteristics

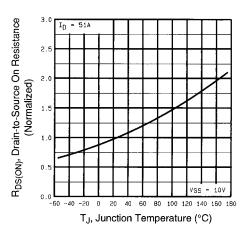


Fig 4. Normalized On-Resistance Vs. Temperature

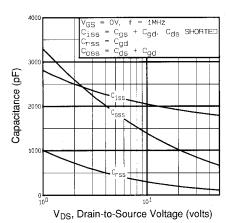


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

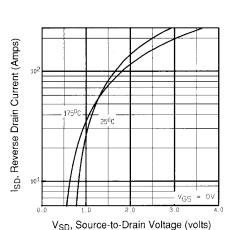


Fig 7. Typical Source-Drain Diode Forward Voltage

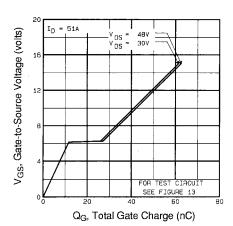


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

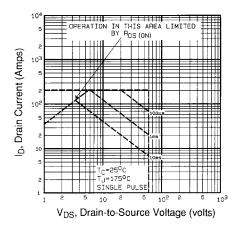


Fig 8. Maximum Safe Operating Area

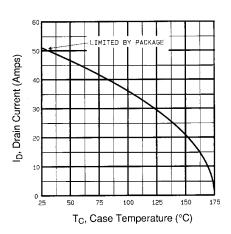


Fig 9. Maximum Drain Current Vs. Case Temperature

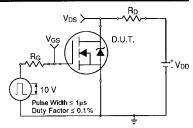


Fig 10a. Switching Time Test Circuit

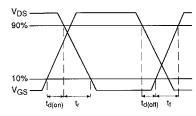


Fig 10b. Switching Time Waveforms

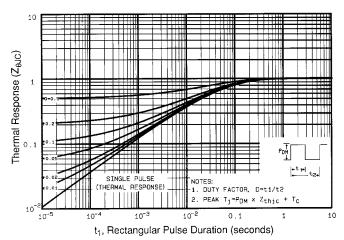


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

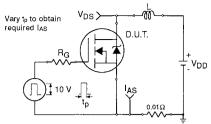


Fig 12a. Unclamped Inductive Test Circuit

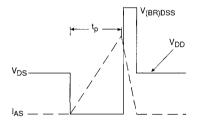


Fig 12b. Unclamped Inductive Waveforms

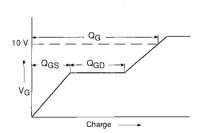


Fig 13a. Basic Gate Charge Waveform

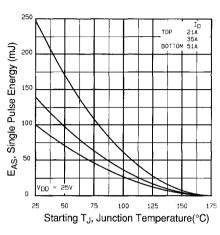


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

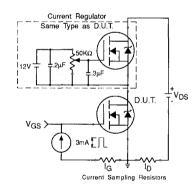


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit – See page 1505

Appendix B: Package Outline Mechanical Drawing - See page 1509

Appendix C: Part Marking Information - See page 1516

Appendix E: Optional Leadforms - See page 1525



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